

**Search Notes**

Application/Control No.

10/677,522

Examiner

Seung H. Lee

Applicant(s)/Patent under  
Reexamination

BARKAN ET AL.

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
235	454	4/4/2005	SHL
235	462.39	4/4/2005	SHL
235	462.40	4/4/2005	SHL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	4/4/2005	SHL